## Notice of References Cited Application/Control No. 10/623,595 Examiner Edwin A. León Applicant(s)/Patent Under Reexamination SOMURA, ATSUSHI Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,450,835 B1	09-2002	Lee, Fred	439/607
*	В	US-6,746,282 B2	06-2004	Meister, Douglas L.	439/638
*	С	US-6,508,670 B1	01-2003	Hwang, Jeng-Yih	439/607
*	D	US-5,782,646	07-1998	Broadfield et al.	439/346
*	E	US-6,524,134	02-2003	Flickinger et al.	439/607
*	F	US-6,478,617 B2	11-2002	Fan, Chia Hao	439/570
*	G	US-5,863,210 A	01-1999	Reisinger, Jason M'Cheyne	439/41
	н	US-			
	-	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.